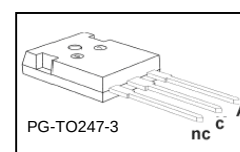
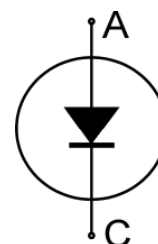


## Fast Switching Emitter Controlled Diode



### Features:

- 600V Emitter Controlled technology
- Fast recovery
- Soft switching
- Low reverse recovery charge
- Low forward voltage
- 175°C junction operating temperature
- Easy paralleling
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models:  
<http://www.infineon.com>



### Applications:

- Welding
- Motor drives

| Type      | $V_{RRM}$ | $I_F$ | $V_{F,TJ=25^{\circ}C}$ | $T_{j,max}$ | Marking | Package    |
|-----------|-----------|-------|------------------------|-------------|---------|------------|
| IDW100E60 | 600V      | 100A  | 1.65V                  | 175°C       | D100E60 | PG-TO247-3 |

### Maximum Ratings

| Parameter                                                      | Symbol    | Value      | Unit |
|----------------------------------------------------------------|-----------|------------|------|
| Repetitive peak reverse voltage                                | $V_{RRM}$ | 600        | V    |
| Continuous forward current                                     | $I_F$     | 150        | A    |
| $T_C = 25^{\circ}C$                                            |           | 104        |      |
| $T_C = 90^{\circ}C$                                            |           | 96         |      |
| Surge non repetitive forward current                           | $I_{FSM}$ | 400        | A    |
| $T_C = 25^{\circ}C$ , $t_p = 10$ ms, sine halfwave             |           |            |      |
| Maximum repetitive forward current                             | $I_{FRM}$ | 300        | A    |
| $T_C = 25^{\circ}C$ , $t_p$ limited by $t_{j,max}$ , $D = 0.5$ |           |            |      |
| Power dissipation                                              | $P_{tot}$ | 375        | W    |
| $T_C = 25^{\circ}C$                                            |           | 212        |      |
| $T_C = 90^{\circ}C$                                            |           | 198        |      |
| Operating junction temperature                                 | $T_j$     | -40...+175 | °C   |
| Storage temperature                                            | $T_{stg}$ | -55...+150 |      |
| Soldering temperature<br>1.6mm (0.063 in.) from case for 10 s  | $T_s$     | 260        |      |

### Thermal Resistance

| Parameter                                 | Symbol     | Conditions | Max. Value | Unit |
|-------------------------------------------|------------|------------|------------|------|
| <b>Characteristic</b>                     |            |            |            |      |
| Thermal resistance,<br>junction – case    | $R_{thJC}$ |            | 0.40       | K/W  |
| Thermal resistance,<br>junction – ambient | $R_{thJA}$ |            | 40         |      |

### Electrical Characteristic, at $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter | Symbol | Conditions | Value |      |      | Unit |
|-----------|--------|------------|-------|------|------|------|
|           |        |            | min.  | typ. | max. |      |

#### Static Characteristic

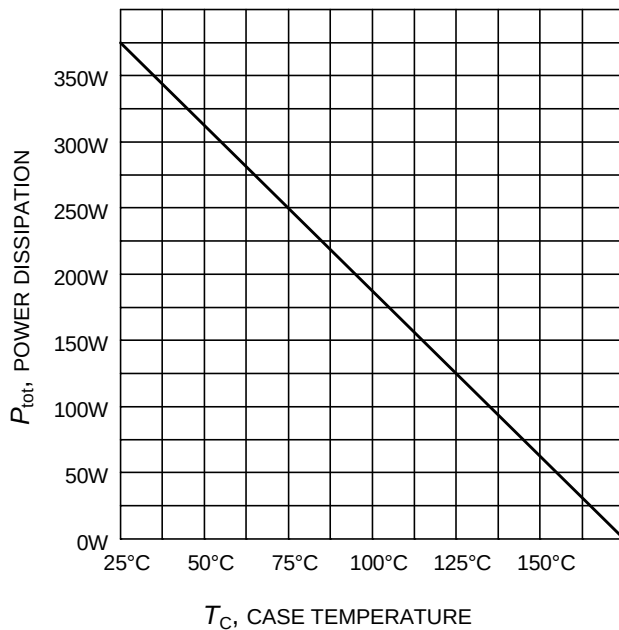
|                                     |           |                                                 |     |      |      |               |
|-------------------------------------|-----------|-------------------------------------------------|-----|------|------|---------------|
| Collector-emitter breakdown voltage | $V_{RRM}$ | $I_R = 0.25\text{mA}$                           | 600 | -    | -    | V             |
| Diode forward voltage               | $V_F$     | $I_F = 100\text{A}$<br>$T_j = 25^\circ\text{C}$ | -   | 1.65 | 2.0  |               |
|                                     |           | $T_j = 175^\circ\text{C}$                       | -   | 1.65 | -    |               |
| Reverse leakage current             | $I_R$     | $V_R = 600\text{V}$<br>$T_j = 25^\circ\text{C}$ | -   | -    | 40   | $\mu\text{A}$ |
|                                     |           | $T_j = 175^\circ\text{C}$                       | -   | -    | 3300 |               |

#### Dynamic Electrical Characteristics

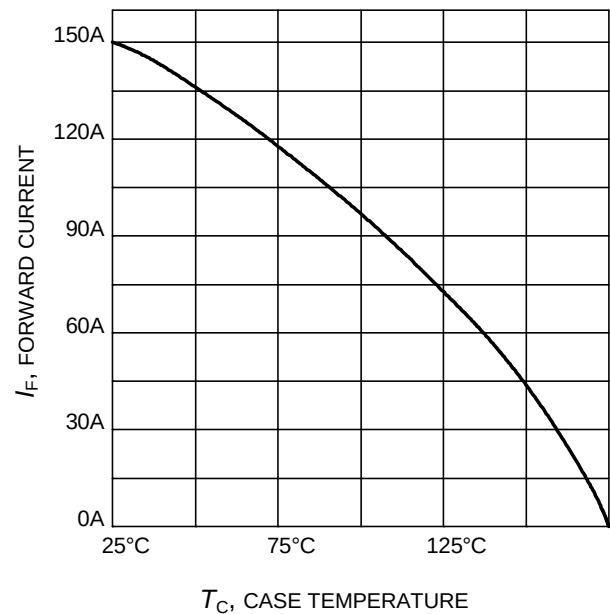
|                                                                  |              |                                      |   |      |   |                        |
|------------------------------------------------------------------|--------------|--------------------------------------|---|------|---|------------------------|
| Diode reverse recovery time                                      | $t_{rr}$     | $T_j = 25^\circ\text{C}$             | - | 120  | - | ns                     |
| Diode reverse recovery charge                                    | $Q_{rr}$     | $V_R = 400\text{V}$ ,                | - | 3.6  | - | $\mu\text{C}$          |
| Diode peak reverse recovery current                              | $I_{rr}$     | $I_F = 100\text{A}$ ,                | - | 49.5 | - | A                      |
| Diode peak rate of fall of reverse recovery current during $t_b$ | $dI_{rr}/dt$ | $dI_F/dt = 1200\text{A}/\mu\text{s}$ | - | 750  | - | $\text{A}/\mu\text{s}$ |

|                                                                  |              |                                      |   |      |   |                        |
|------------------------------------------------------------------|--------------|--------------------------------------|---|------|---|------------------------|
| Diode reverse recovery time                                      | $t_{rr}$     | $T_j = 125^\circ\text{C}$            | - | 168  | - | ns                     |
| Diode reverse recovery charge                                    | $Q_{rrm}$    | $V_R = 400\text{V}$ ,                | - | 5.8  | - | $\mu\text{C}$          |
| Diode peak reverse recovery current                              | $I_{rr}$     | $I_F = 100\text{A}$ ,                | - | 61.6 | - | A                      |
| Diode peak rate of fall of reverse recovery current during $t_b$ | $dI_{rr}/dt$ | $dI_F/dt = 1200\text{A}/\mu\text{s}$ | - | 705  | - | $\text{A}/\mu\text{s}$ |

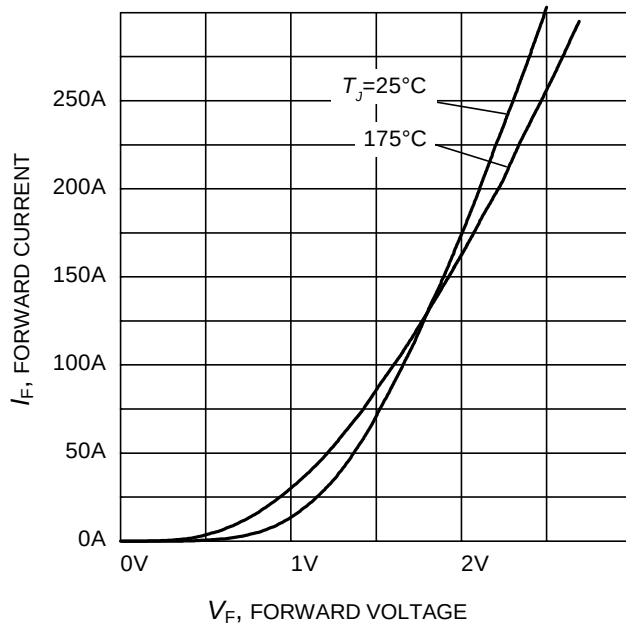
|                                                                  |              |                                      |   |      |   |                        |
|------------------------------------------------------------------|--------------|--------------------------------------|---|------|---|------------------------|
| Diode reverse recovery time                                      | $t_{rr}$     | $T_j = 175^\circ\text{C}$            | - | 200  | - | ns                     |
| Diode reverse recovery charge                                    | $Q_{rrm}$    | $V_R = 400\text{V}$ ,                | - | 7.8  | - | $\mu\text{C}$          |
| Diode peak reverse recovery current                              | $I_{rr}$     | $I_F = 100\text{A}$ ,                | - | 67.0 | - | A                      |
| Diode peak rate of fall of reverse recovery current during $t_b$ | $dI_{rr}/dt$ | $dI_F/dt = 1200\text{A}/\mu\text{s}$ | - | 650  | - | $\text{A}/\mu\text{s}$ |



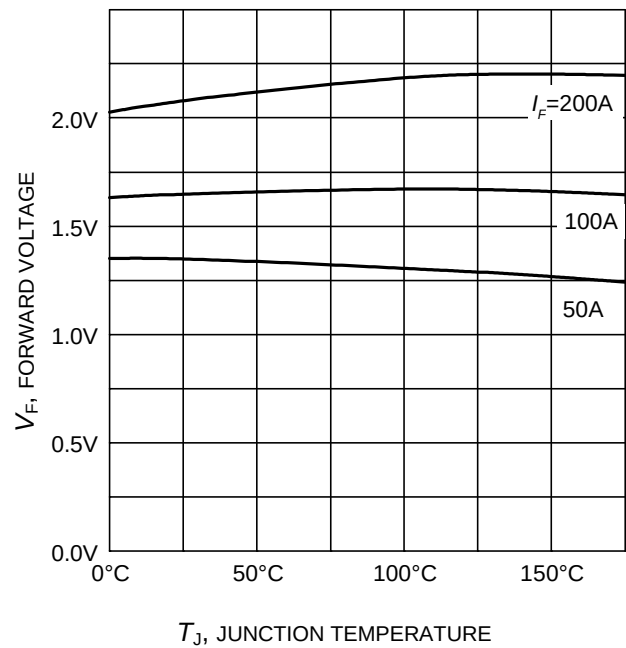
**Figure 1. Power dissipation as a function of case temperature**  
( $T_j \leq 175^\circ\text{C}$ )



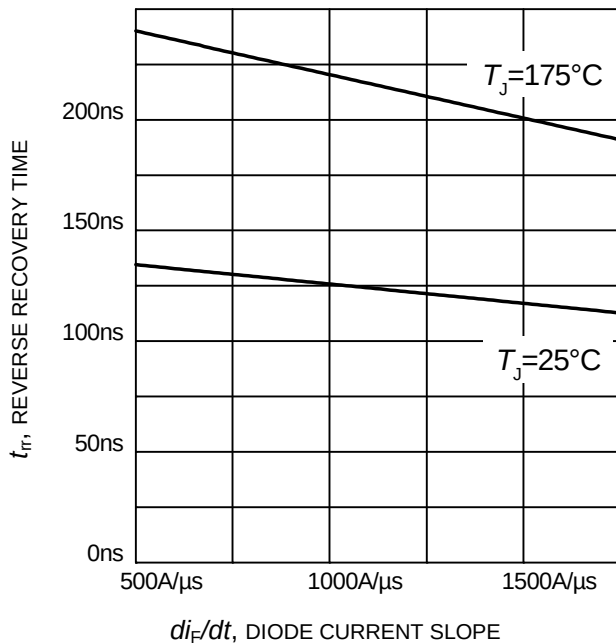
**Figure 2. Diode forward current as a function of case temperature**  
( $T_j \leq 175^\circ\text{C}$ )



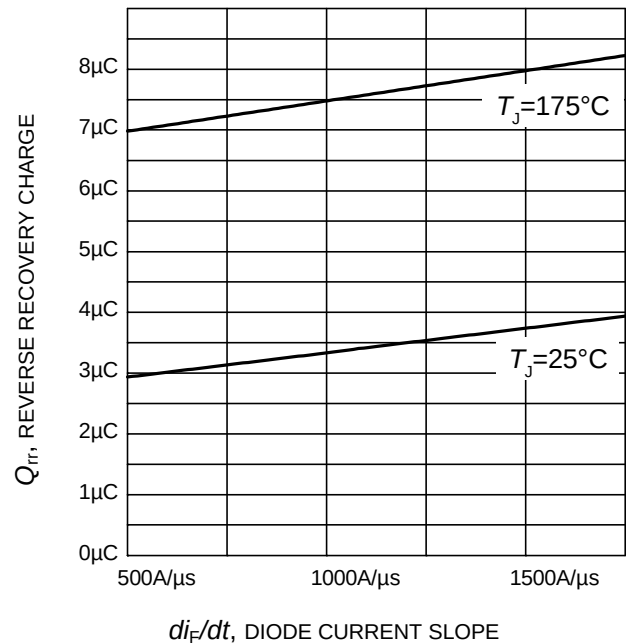
**Figure 3. Typical diode forward current as a function of forward voltage**



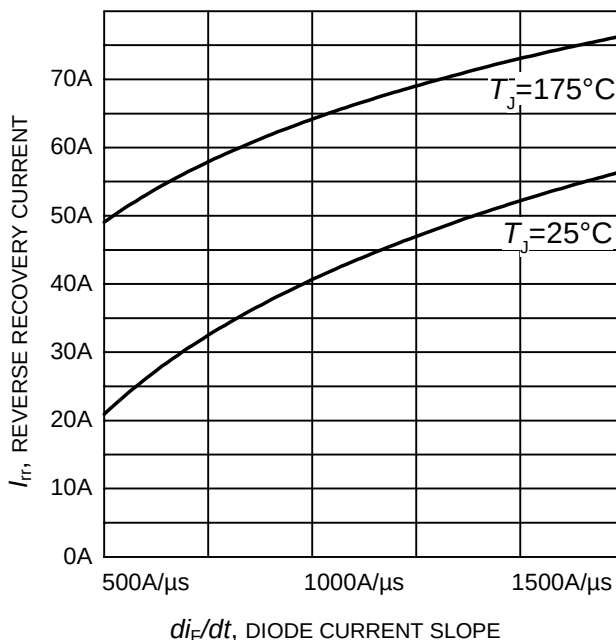
**Figure 4. Typical diode forward voltage as a function of junction temperature**



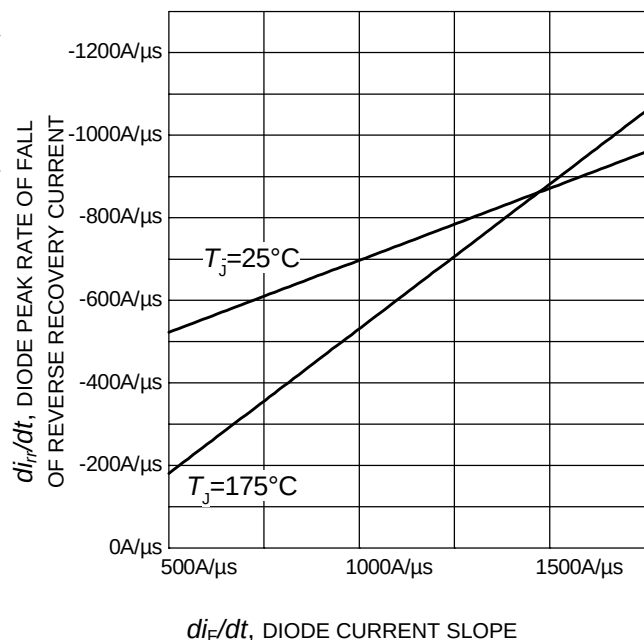
**Figure 5. Typical reverse recovery time as a function of diode current slope**  
( $V_R=400\text{V}$ ,  $I_F=100\text{A}$ ,  
Dynamic test circuit in Figure E)



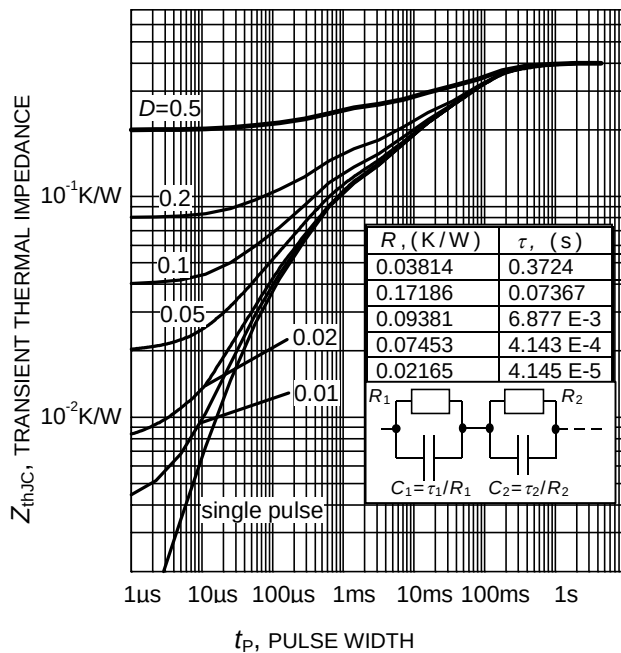
**Figure 6. Typical reverse recovery charge as a function of diode current slope**  
( $V_R = 400\text{V}$ ,  $I_F = 100\text{A}$ ,  
Dynamic test circuit in Figure E)



**Figure 7. Typical reverse recovery current as a function of diode current slope**  
( $V_R = 400\text{V}$ ,  $I_F = 100\text{A}$ ,  
Dynamic test circuit in Figure E)

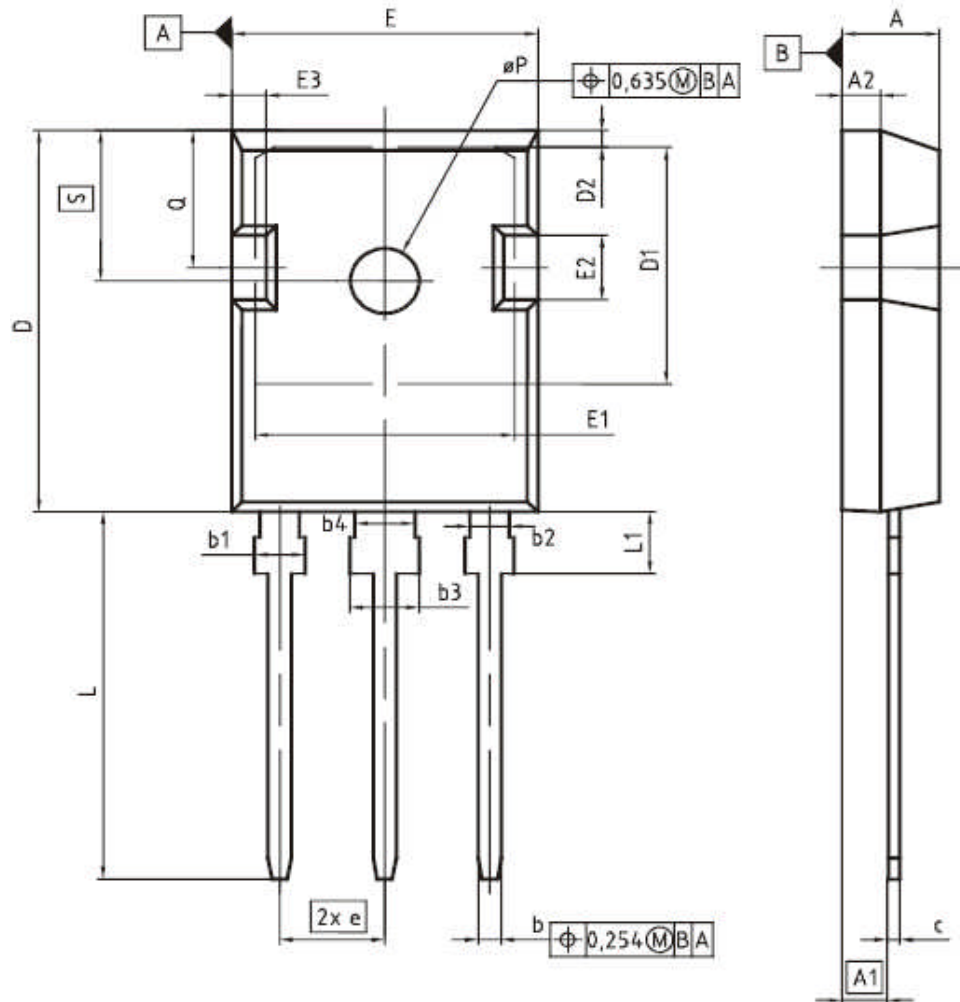


**Figure 8. Typical diode peak rate of fall of reverse recovery current as a function of diode current slope**  
( $V_R=400\text{V}$ ,  $I_F=100\text{A}$ ,  
Dynamic test circuit in Figure E)

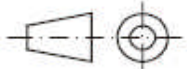


**Figure 9. Diode transient thermal impedance as a function of pulse width**  
 $(D=t_p/T)$

## PG-TO247-3



| DIM | MILLIMETERS |       | INCHES      |       |
|-----|-------------|-------|-------------|-------|
|     | MIN         | MAX   | MIN         | MAX   |
| A   | 4,83        | 5,21  | 0,190       | 0,205 |
| A1  | 2,27        | 2,54  | 0,089       | 0,100 |
| A2  | 1,85        | 2,16  | 0,073       | 0,085 |
| b   | 1,07        | 1,33  | 0,042       | 0,052 |
| b1  | 1,90        | 2,41  | 0,075       | 0,095 |
| b2  | 1,90        | 2,16  | 0,075       | 0,085 |
| b3  | 2,87        | 3,38  | 0,113       | 0,133 |
| b4  | 2,87        | 3,13  | 0,113       | 0,123 |
| c   | 0,55        | 0,68  | 0,022       | 0,027 |
| D   | 20,80       | 21,10 | 0,819       | 0,831 |
| D1  | 16,25       | 17,65 | 0,640       | 0,695 |
| D2  | 0,95        | 1,35  | 0,037       | 0,053 |
| E   | 15,70       | 16,13 | 0,618       | 0,635 |
| E1  | 13,10       | 14,15 | 0,516       | 0,557 |
| E2  | 3,68        | 5,10  | 0,145       | 0,201 |
| E3  | 1,00        | 2,60  | 0,039       | 0,102 |
| e   | 5,44 (BSC)  |       | 0,214 (BSC) |       |
| N   | 3           |       | 3           |       |
| L   | 19,80       | 20,32 | 0,780       | 0,800 |
| L1  | 4,10        | 4,47  | 0,161       | 0,176 |
| øP  | 3,50        | 3,70  | 0,138       | 0,146 |
| Q   | 5,49        | 6,00  | 0,216       | 0,236 |
| S   | 6,04        | 6,30  | 0,238       | 0,248 |

|                                                                                       |                   |
|---------------------------------------------------------------------------------------|-------------------|
| DOCUMENT NO.<br>Z8B00003327                                                           |                   |
| SCALE                                                                                 | 0<br>5 5<br>7,5mm |
| EUROPEAN PROJECTION                                                                   |                   |
|  |                   |
| ISSUE DATE<br>09-07-2010                                                              |                   |
| REVISION<br>05                                                                        |                   |

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